

## Special Issue

# Fault Detection and State Estimation in Automatic Control

### Message from the Guest Editors

This Special Issue aims to focus on intelligent control, intelligent modeling, computational intelligence, artificial intelligence, machine learning, and fault detection. This fits the scope of *Applied Sciences* as the practical applications of fault detection and machine learning are incredibly extensive and important. In this Special Issue, original research articles and reviews are welcome. Research areas may include (but are not limited to) the following:

- Design and application of fault detection algorithms;
- Design and application of state estimation methods;
- Design and application of machine learning algorithms;
- Automatic control system characteristics analysis;
- Design and application of intelligent control systems.

### Guest Editors

Prof. Dr. Sheng Du

Dr. Wei Wang

Dr. Hao Fu

Prof. Dr. Xiongbo Wan

### Deadline for manuscript submissions

closed (31 August 2023)



## Applied Sciences

---

an Open Access Journal  
by MDPI

---

Impact Factor 2.5  
CiteScore 5.5



[mdpi.com/si/130699](https://mdpi.com/si/130699)

*Applied Sciences*  
Editorial Office  
MDPI, Grosspeteranlage 5  
4052 Basel, Switzerland  
Tel: +41 61 683 77 34  
[appls@mdpi.com](mailto:appls@mdpi.com)

[mdpi.com/journal/](https://mdpi.com/journal/)

[appls](https://appls.mdpi.com)





# Applied Sciences

---

an Open Access Journal  
by MDPI

---

Impact Factor 2.5  
CiteScore 5.5



[mdpi.com/journal/  
applsci](https://mdpi.com/journal/applsci)



## About the Journal

### Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

---

### Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo  
Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32,  
20133 Milano, Italy

---

### Author Benefits

#### Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

#### High Visibility:

indexed within Scopus, SCIE (Web of Science), Ei Compendex, Inspec, CAPlus / SciFinder, and other databases.

#### Journal Rank:

JCR - Q2 (Engineering, Multidisciplinary) / CiteScore - Q1 (General Engineering )